



Characterization of Wavelength Selective Photonic Switches for Scalable Data Center

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ESEPcenter for science and engineering partnerships



 In 2014, data centers in USA consumed 70 billion kWh ~2% of total energy!¹

Microsoft tests underwater data center

Photonics

- Secure communication
- Faster data processing
- Energy efficient!



1. https://eta.lbl.gov/publications/united-states-data-center-energy

2. https://news.microsoft.com/features/under-the-sea-microsoft-tests-a-datacenter-thats-quick-to-deploy-could-provide-internet-connectivity-foryears/

Wavelength Division Multiplexing



- Signals are combined (MUX) into one fiber
- Signals are re-routed from one channel to another and separated out (DEMUX)
- This process can be scaled down with integrated photonics

Wavelength Selective Switch



- Resonant wavelengths are thermally tuned
- One signal can be <u>added</u> to the same path of another signal

 Input signal can also be <u>dropped</u> off to another path

Integrated Photonics Switch Design



- Electrical-Pads
- Optical-Switches
- Optical-Edge
 Couplers
 - Fabricated through the AIM Photonics foundry

Coupling to Channels



1. Maximizing the Transfer Function of Switches



- Transfer function is measured from the drop port
- Goal is to maximize coupling into 2 sets of second order rings
- Create 3.2 nm separation between resonant peak
- Working in the telecommunication wavelength (C-band: 1530 nm – 1565 nm)

2. Bit Error Rate Test



- Modulated signal is sent at the resonant wavelength of one pair of rings
- Inability to distinguish signal correctly generates errors
- Known bits of signal is compared with to determine number of errors



- Distinguishable lines: Low noise and jitter
- Symmetric open eye: wide bandwidth and high signal

3. Switching (Rise/Fall) Time



Ports Under Test



Transfer Function



Bit Error Rate Test





Switching Time Oscilloscope



 Switching time is shown for a thermal tuner in IO 1 • Time axis includes negative value because oscilloscope set t=0 when triggered

Switching Time



Conclusion

•Able to simultaneously switch 2 wavelengths and separate local maxima by 3.2 nm to reduce optical cross talk

- •BER test demonstrates a low error rate of 10⁹ for IO1 @ 15 dBm optical attenuation but needs to be repeated
- •Coupling decreases with increasing I/O #, resulting in lower signal to noise ratio (SNR)
- •Eye diagram show high noise and jitter but wide bandwidth
- •Optical power is reduced by >50% at 4 V difference, which requires less than 5 us switching time

Future Work

- BER test needs to be repeated for all the I/O
- Repeat the above experiments with a fiber array
- Reduce noise and measure optical crosstalk
- Decrease switching time with a material that allows electrooptic tuning (i.e. lithium niobate) or through carrier depletion

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